



<b>FORM PTO-1449</b>  <b>INFORMATION DISCLOSURE STATEMENT</b>	<b>DOCKET NO:</b>	<b>SERIAL NO.:</b>
	70868/56837	10/019,639
	<b>APPLICANT(S):</b> M. Shimada, et al.	
	<b>FILING DATE:</b>	<b>GROUP NO.:</b>
	December 28, 2001	Unassigned

**UNITED STATES PATENT DOCUMENTS**

EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

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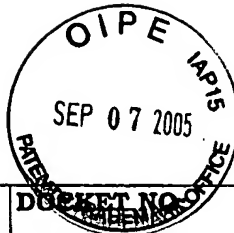
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**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
WDH	BA	JP5199398	08/06/1993	JAPAN			Abstract
WDH	BB	JP10307460	11/17/1998	JAPAN			Abstract
WDH	BC	JP5048870	02/26/1993	JAPAN			Abstract
WDH	BD	JP4003655	01/08/1992	JAPAN			Abstract
WDH	BE	JP2264566	10/29/1990	JAPAN			Abstract
WDH	BF	JP63142769	06/15/1988	JAPAN			Abstract

**OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)**

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<b>EXAMINER:</b>	<b>DATE:</b>
	6 May 2005



FORM PTO-1449

DUCKET NO.:  
56837 (70868)SERIAL NO.:  
10/019,639INFORMATION DISCLOSURE  
STATEMENT

APPLICANT(S): M. Shimada, et al.

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## UNITED STATES PATENT DOCUMENTS

EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
WDH	AA	5,970,183	10/19/1999	M. Amemiya, et al.	<del>382</del>	<del>282</del>	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

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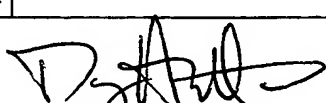
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
WDH	BA	8-289092	11/01/1996	JAPAN			Abstract
WDH	BB	9-37057	02/07/1997	JAPAN			Abstract
WDH	BC	9-139835	05/27/1997	JAPAN			Abstract
WDH	BD	9-186854	07/15/1997	JAPAN			Abstract
WDH	BE	9-191390	07/22/1997	JAPAN			Abstract
WDH	BF	9-261448	10/03/1997	JAPAN			Abstract
WDH	BG	9-284491	10/31/1997	JAPAN			Abstract
WDH	BH	10-178520	06/30/1998	JAPAN			Abstract
WDH	BI	11-164102	06/18/1999	JAPAN			Abstract

## OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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EXAMINER:		DATE: 6 May 2005

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**Notice of References Cited**

Application/Control No.

10/019,639

Applicant(s)/Patent Under  
Reexamination  
SHIMADA ET AL.

Examiner

Doug Hutton

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,836,568	12-2004	Morishita, Tadao	382/283
	B	US-6,456,732	09-2002	Kimbell et al.	715/521
	C	US-6,043,823	03-2000	Kodaira et al.	345/619
	D	US-5,719,968	02-1998	Hashimoto et al.	382/289
	E	US-5,483,606	01-1996	Denber, Michel J.	382/294
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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